



Product Summary

V _{(BR)DSS}	R _{DS(on)}	I _D max T _A = +25℃
	320mΩ @ V _{GS} = 4.5V	1.0A
20V	500mΩ @ V _{GS} = 2.5V	0.65A
	1000mΩ@V _{GS} = 1.8V	0.4A

Description and Applications

This MOSFET is designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Load switch

20V N-CHANNEL ENHANCEMENT MODE MOSFET

Features and Benefits

- Footprint of just 0.6mm² thirteen times smaller than SOT23
- 0.4mm profile ideal for low profile applications
- Low Gate Threshold Voltage
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- ESD Protected Gate 2KV

Mechanical Data

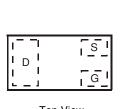
- Case: X2-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @
- Weight: 0.001 grams (Approximate)



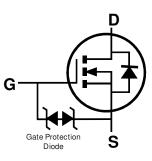


X2-DFN1006-3

Bottom View



Top View Internal Schematic



Equivalent Circuit

Ordering Information (Note 4)

Part Number	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMN2320UFB4-7B	ND	7	8	10,000

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

Notes:

DMN2320UFB4-7B



Top View Bar Denotes Gate and Source Side ND = Product Type Marking Code



Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V _{DSS}	20	V
Gate-Source Voltage			V _{GSS}	±8	V
Continuous Drain Current (Note 6) V_{GS} = 4.5V	Steady State	T _A = +25 ℃ T _A = +100 ℃	ID	1.0 0.7	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I _{DM}	6	A

Thermal Characteristics (@T_A = +25 °C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	PD	0.52	W
Total Power Dissipation (Note 6)	PD	1.07	W
Thermal Resistance, Junction to Ambient (Note 5)	R _{0JA}	240	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	R _{0JA}	117	°C/W
Operating and Storage Temperature Range	TJ, T _{STG}	-55 to +150	C

Electrical Characteristics (@T_A = +25 °C, unless otherwise specified.)

			-			T 10 100
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)		1				
Drain-Source Breakdown Voltage	BV _{DSS}	20	-	-	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current T _J = +25 °C	I _{DSS}	-	-	1	μA	$V_{DS} = 20V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	10	μA	$V_{GS} = \pm 8V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(th)}	0.50	-	0.95	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
		-	-	320	mΩ	$V_{GS} = 4.5V, I_D = 500mA$
Static Drain-Source On-Resistance	R _{DS (ON)}	-	-	500		$V_{GS} = 2.5V, I_D = 400mA$
		-	'	1,000		$V_{GS} = 1.8V, I_{D} = 100mA$
Diode Forward Voltage	V _{SD}	-	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 300mA$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	Ciss	-	71	-	pF	
Output Capacitance	Coss	-	12	-	pF	V _{DS} = 10V, V _{GS} = 0V, f = 1.0MHz
Reverse Transfer Capacitance	Crss	-	9.4	-	pF	
Gate Resistance	Rg	-	69	-	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$
Total Gate Charge	Qg	-	0.89	-	nC	
Gate-Source Charge	Qgs	-	0.14	-	nC	V _{GS} = 4.5V, V _{DS} = 10V, In = 1A
Gate-Drain Charge	Q _{gd}	-	0.16	-	nC	ID = IA
Turn-On Delay Time	t _{D(on)}	-	4.9	-	ns	
Turn-On Rise Time	tr	-	6.9	-	ns	V _{DS} = 10V, I _D = 1A
Turn-Off Delay Time	t _{D(off)}	-	21.7	-	ns	$V_{GS} = 4.5V, R_G = 6\Omega$
Turn-Off Fall Time	tf	-	10.6	-	ns	

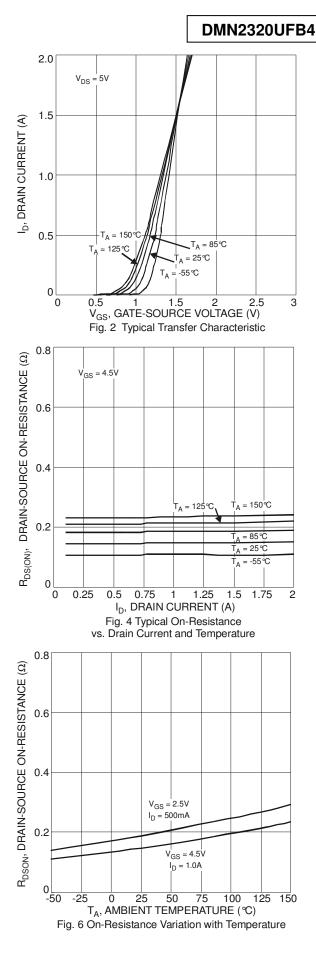
Notes:

Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
Device mounted on FR-4 substrate PC board, 2oz copper, with 25mm X 25mm square copper plate.

Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing.

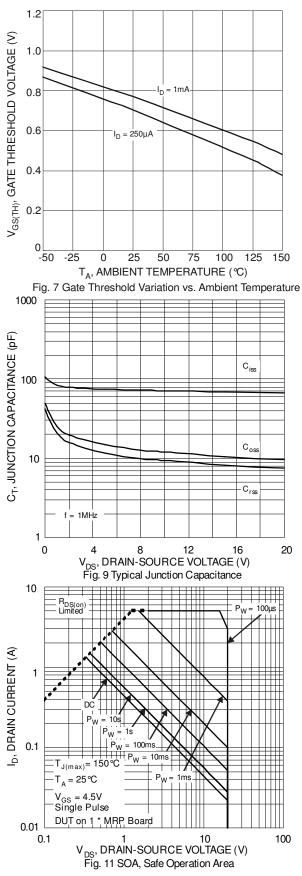


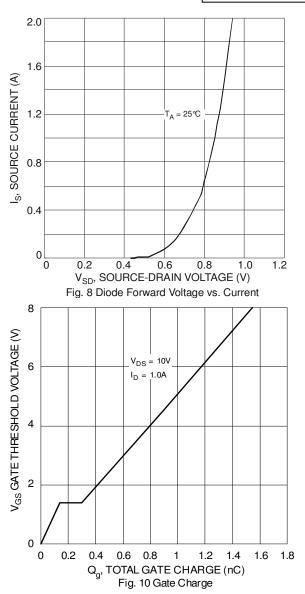
2.0 = 4.5V = 2.5V 35 2.0V GS 1.8V 1.5 GS I_D, DRAIN CURRENT (A) V_{GS} = 1.5V 1.0 0.5 V_{GS} = 1.2V 0 1 2 3 4 V_{DS}, DRAIN-SOURCE VOLTAGE (V) 5 0 Fig. 1 Typical Output Characteristic 0.4 $R_{\text{DS}(\text{ON})},$ DRAIN-SOURCE ON-RESISTANCE (Ω) 0.3 0.2 V_{GS} = 2.5V $V_{GS} = 4.5V$ 0.1 0∟ 0 0.4 0.8 1.2 1.6 I_D, DRAIN-SOURCE CURRENT (A) 2 Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage 1.6 $V_{GS} = 4.5V$ R_{DSON}, DRAIN-SOURCE ON-RESISTANCE (NORMALIZED) = 1.0A 1.4 I_D $V_{GS} = 2.5V$ $I_{D} = 500mA$ 1.2 1.0 0.8 0.6 125 150 -50 -25 0 25 50 75 100 T_A, AMBIENT TEMPERATURE (℃) Fig. 5 On-Resistance Variation with Temperature



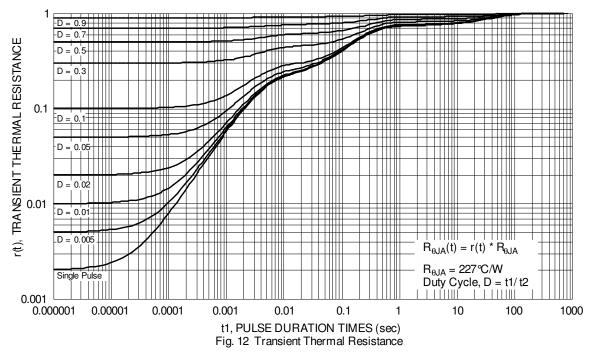








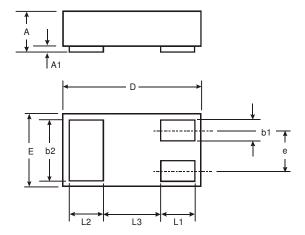






Package Outline Dimensions

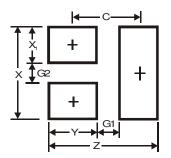
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



X2-DFN1006-3						
Dim	Min	Max	Тур			
Α		0.40				
A1	0	0.05	0.03			
b1	0.10	0.20	0.15			
b2	0.45	0.55	0.50			
D	0.95	1.05	1.00			
E	0.55	0.65	0.60			
е			0.35			
L1	0.20	0.30	0.25			
L2	0.20	0.30	0.25			
L3			0.40			
All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	1.1
G1	0.3
G2	0.2
Х	0.7
X1	0.25
Y	0.4
С	0.7



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